

450V N-Channel MOSFET

General Features

- Proprietary New Planar Technology
- \succ R_{DS(ON),typ}.=0.30 Ω@V_{GS}=10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- Ballast and Lighting
- DC-AC Inverter
- Other Applications

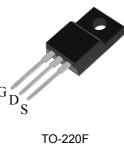
Ordering Information

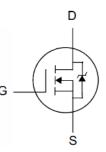
Part Number	Package	Brand
PTA13N45	TO-220F	ž

Absolute Maximum Ratings



BV _{DSS}	R _{DS(ON),typ.}	I _D
450V	0.30Ω	13A





Package No to Scale

 $T_C {=} 25\,^\circ\!\mathrm{C}$ unless otherwise specified

Symbol	Parameter	PTA13N45	Unit
V _{DSS}	Drain-to-Source Voltage ^[1]	450	V
V _{GSS}	Gate-to-Source Voltage	±30	v
ID	Continuous Drain Current	13	
I D @ Tc =100 ℃	Continuous Drain Current @ Tc=100℃	Figure 3	A
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2]	Figure 6	
E _{AS}	Single Pulse Avalanche Energy	550	mJ
dv/dt	Peak Diode Recovery dv/dt ^[3]	5.0	V/ns
D	Power Dissipation	63	W
P _D	Derating Factor above 25°C	0.50	W/°C
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	°C
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter PTA13N45		Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	1.98	10.111
R _{θJA}	Thermal Resistance, Junction-to-Ambient	100	°C /W

Electrical Characteristics

OFF Characteristics $T_J = 25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	450			V	V_{GS} =0V, I _D =250uA
	I _{DSS} Drain-to-Source Leakage Current			1		V _{DS} =450V, V _{GS} =0V
IDSS				100	uA	V _{DS} =360V, V _{GS} =0V, T _J =125℃
	Cate to Source Leakage Current			+100		V _{GS} =+30V, V _{DS} =0V
I _{GSS}	Gate-to-Source Leakage Current			-100	nA	V _{GS} =-30V, V _{DS} =0V

ON Characteristics

ON Characteristics			T_J =25 $^\circ\!$			
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance ^[4]		0.30	0.45	Ω	V_{GS} =10V, I _D =6.5A
$V_{GS(TH)}$	Gate Threshold Voltage	2.0		4.0	V	V_{DS} = V_{GS} , I_D =250uA
gfs	Forward Transconductance ^[4]		22		S	VDS=20V,ID=13A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		1600		pF	V _{GS} =0V, V _{DS} =25V, f=1.0MH _Z
C _{rss}	Reverse Transfer Capacitance		16			
C _{oss}	Output Capacitance		150			
Qg	Total Gate Charge		30			
Q _{gs}	Gate-to-Source Charge		8.0		nC	V_{DD} =225V, I _D =13A, V_{GS} =0 to 10V
Q _{gd}	Gate-to-Drain (Miller) Charge		8.0			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		20			
trise	Rise Time		12			V _{DD} =225V, ID =13A,
td(OFF)	Turn-Off Delay Time		80		nS	V _{GS} = 10V Rg=12Ω
tfall	Fall Time		30			

Source-Drain Body Diode Characteristics

 $T_J {=} 25\,^\circ\!\mathrm{C}$ unless otherwise specified

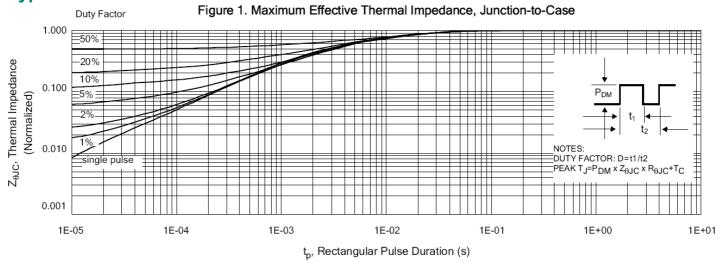
Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[4]			13	A	Integral PN-diode in MOSFET
I _{SM}	Pulsed Source Current ^[4]			52		
V_{SD}	Diode Forward Voltage			1.5	V	I _S =13A, V _{GS} =0V
trr	Reverse recovery time		300		ns	V _{GS} =0V ,I⊧=13A,
Qrr	Reverse recovery charge		2.5		uC	di⊧/dt=100A/µs

Note:

[1] T_J=+25℃ to +150℃

- [2] Repetitive rating; pulse width limited by maximum junction temperature. [3] IsD= 13A di/dt < 100 A/ μ s, VDD < BVDss, TJ=+150 °C.
- [4] Pulse width≤380µs; duty cycle≤2%.

Typical Characteristics



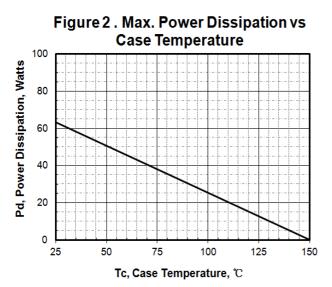


Figure 4. Typical Output Characteristics

10

V_{DS}, Drain-to-Source Voltage (V)

VGS

 $V_{GS} = 7.0V$

V_{GS} = 6.5V

 $V_{GS} = 6.0V$

 $V_{GS} = 5.5V$

 $V_{GS} = 5.0V$

20

15

PULSE DURATION = 250 µS

DUTY FACTOR = 0.5% MAX

5

 $T_C = 25^{\circ}C$

25

20

15

10

5

0

0

I_D, Drain Current (A)

Figure 3 .Maximum Continuous Drain Current vs Tc

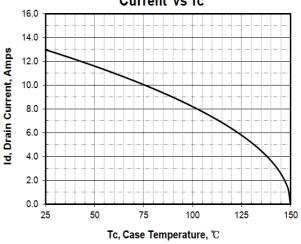
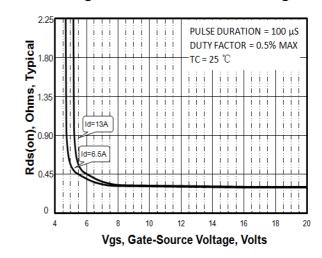


Figure 5. Rdson vs Gate Voltage



Typical Characteristics(Cont.)

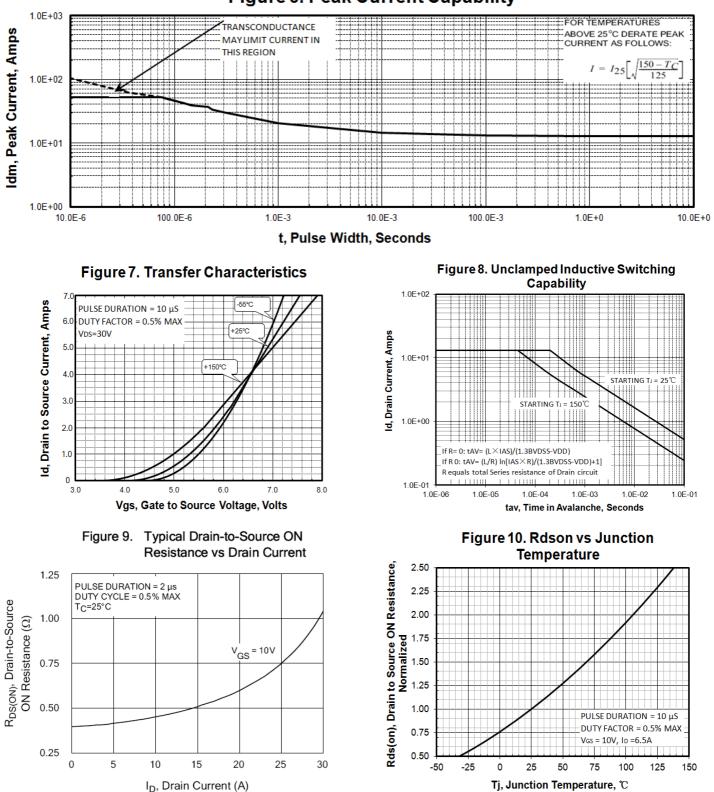
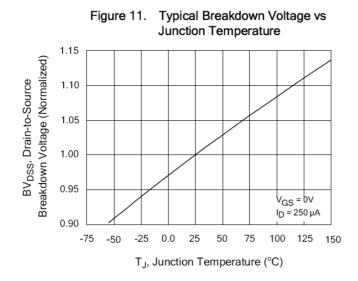
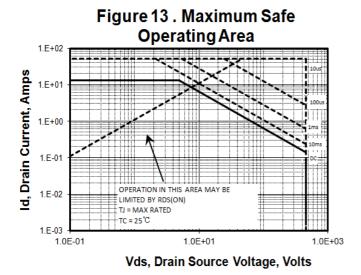


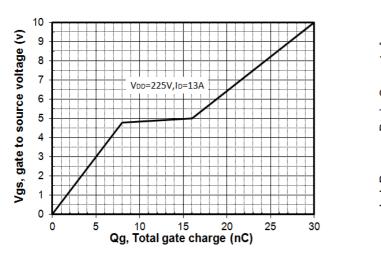
Figure 6. Peak Current Capability

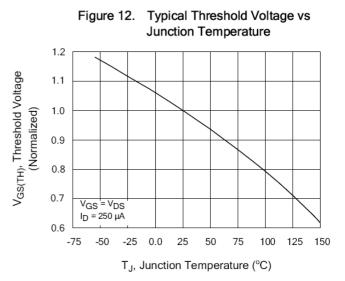
Typical Characteristics(Cont.)

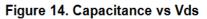


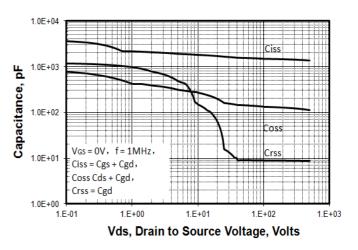




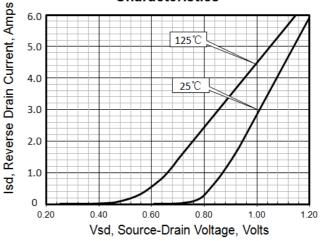




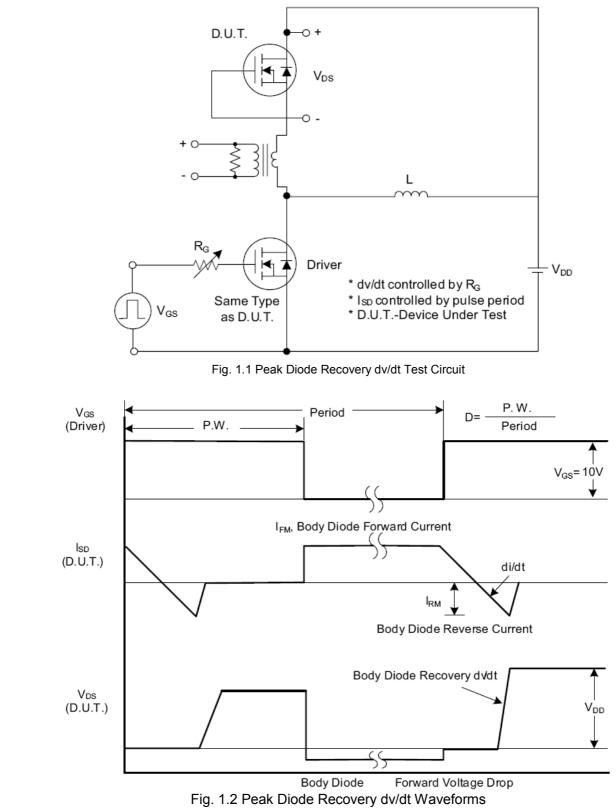








Test Circuits and Waveforms



2

PTA13N45

Test Circuits and Waveforms (Cont.)

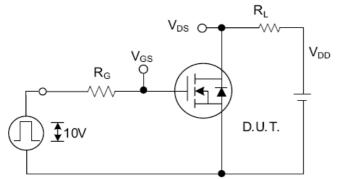


Fig. 2.1 Switching Test Circuit

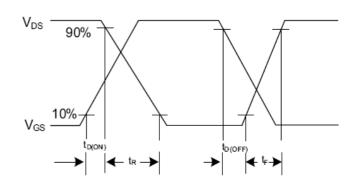


Fig. 2.2 Switching Waveforms

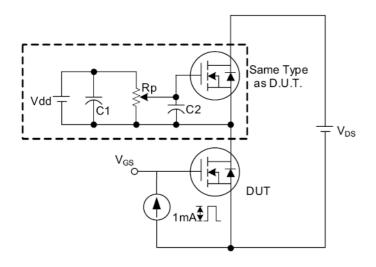


Fig. 3 . 1 Gate Charge Test Circuit

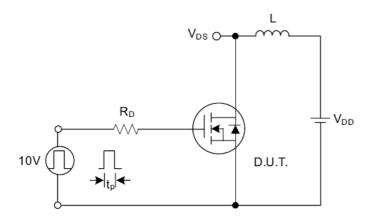


Fig. 4.1 Unclamped Inductive Switching Test Circuit

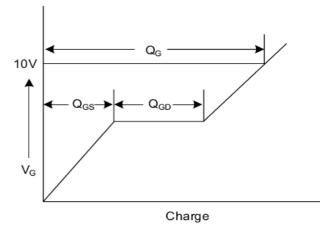
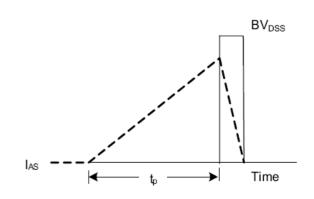
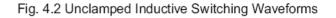


Fig. 3.2 Gate Charge Waveform





Disclaimers:

Perfect Intelligent Power Semiconductor Co., Ltd (PIP) reserves the right to make changes without notice in order to improve reliability, function or design and to discontinue any product or service without notice. Customers should obtain the latest relevant information before orders and should verify that such information is current and complete. All products are sold subject to PIP's terms and conditions supplied at the time of order acknowledgement.

Perfect Intelligent Power Semiconductor Co., Ltd warrants performance of its hardware products to the specifications at the time of sale, Testing, reliability and quality control are used to the extent PIP deems necessary to support this warrantee. Except where agreed upon by contractual agreement, testing of all parameters of each product is not necessarily performed.

Perfect Intelligent Power Semiconductor Co., Ltd does not assume any liability arising from the use of any product or circuit designs described herein. Customers are responsible for their products and applications using PIP's components. To minimize risk, customers must provide adequate design and operating safeguards.

Perfect Intelligent Power Semiconductor Co., Ltd does not warrant or convey any license either expressed or implied under its patent rights, nor the rights of others. Reproduction of information in PIP's data sheets or data books is permissible only if reproduction is without modification or alteration. Reproduction of this information with any alteration is an unfair and deceptive business practice. Perfect Intelligent Power Semiconductor Co., Ltd is not responsible or liable for such altered documentation.

Resale of PIP's products with statements different from or beyond the parameters stated by Perfect Intelligent Power Semiconductor Co., Ltd for that product or service voids all express or implied warrantees for the associated PIP's product or service and is unfair and deceptive business practice. Perfect Intelligent Power Semiconductor Co., Ltd is not responsible or liable for any such statements.

Life Support Policy:

Perfect Intelligent Power Semiconductor Co., Ltd's products are not authorized for use as critical components in life support devices or systems without the expressed written approval of Perfect Intelligent Power Semiconductor Co., Ltd.

As used herein:

- 1. Life support devices or systems are devices or systems which:
 - a. are intended for surgical implant into the human body,
 - b. support or sustain life,
 - c. whose failure to perform when properly used in accordance with instructions for used provided in the labeling, can be reasonably expected to result in significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.